То	Digi-Key	Issue No. :	EZJ-3040		
		Date of Issue:	November	12. 2002	
		Classification:			□ Revised

PRODUCT SPECIFICATION FOR INFORMATION

Product Description	:	MULTILAYER VARISTOR CHIP TYPE (ZnO)
Product Part Number	:	EZJZSV270CAK
		EZJZSV270DAK
Classification of Spec	:	SPECIFICATION
Applications	:	
	F	for other applications contact our person signed below.
Term of Validity	:	November 11.2007 from the date of issue
of the validity date mentioned continuously extended one more	in th year ision	is performed during effective term and you have confirmed,

CUSTOMER USE ONLY	Receipt Record # :		
This was certainly received by us.	Date of Receipt :		
l(one) copy is being returned to you.	Received by : Title:		
	Dept:		

Ceramic Business Unit LCR Device Company

Matsushita Electronic Components Co., Ltd.

〒571-8506 1006 Kadoma, Osaka, Japan

Tel: Osaka (06) 6908-1101 Fax: Osaka (06) 6908-7735 Prepared by : Engineering Section

Contact Person:

Title : Engineer

Authorized by :

Title: Manager of Engineering

·This product has not been manufactured with any ozone depleting chemical controlled under the Montreal Protocol.

All the materials used in this part contain no brominated materials of PBBOs or PBBs as the flame retardant.

·All the materials used in this part are registered material under the Law Concerning the Examination and Regulation of Manufacture, etc. of Chemical Substances.

CLASSIFICATION SPECIFICATION REF. No							
PRO	DUCT	MUI		YPE (Zinc Oxide)	151S-EZJZ-S-270CAK		
PART NUMBER			EZJZSV270CAK		1-1		
	Item			Requirements	Test Spe	cifications	
1.Stn	ucture		.	territorio de la constantina del constantina de la constantina de la constantina de la constantina del constantina de la		i i i i i i i i i i i i i i i i i i i	
1.1	Appearance		Without	dirt and crack			
1.2	Dimensions		L	1.37 ± 0.15		!	
			W	1.00 ± 0.15			
			Т	0.66 max.	BW1	W	
			BW	0.36 ± 0.10			
			BW1	0.20 ± 0.10	1		
			P	0.64 ± 0.10	 		
				unit:mm		L	
					BW		
			} }			• !!	
						1	
					-		
					'	P	
2 Elo	ctrical Require			 			
Z.Ele	curcai Require	enients	I		1		
2.1 Maximum allowable			DC 16 V				
	voltage						
		_					
2.2	2.2 Varistor voltage			$27V \pm 15\%$	Measuring current DC 1mA		
	O			22 F + 100/	Measuring voltage	1.0 Vrms.	
2.3	Capacit	ance		$22pF \pm 10\%$.	Measuring frequency	1MHz	
					informating frequency	110112	
2.4	Clamping	voltage		50 Vmax.	Impulse waveform	$8/20\mu$ s	
	<i>O</i>				Impulse current	1A	
					Impulse waveform	8/20 μ s	
2.5	Maximum ne	Maximum peak current		5A	1	2 times	
	р-			V. I	Repetition times		
					L	(5 minutes interval)	
Note:							
	DATE				APPROVAL C	HECK DESIGN	
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PRO	DUCT MU		YPE (Zinc Oxide)	151S-EZJZ-S-270DAK	
PAR	T NUMBER		•		1-1
	Item		Requirements	Test Spe	ecifications
1.Str	ucture			-	
1.1	Appearance	Without	dirt and crack	I	
1.2	Dimensions	L	1.37 ± 0.15	_	!
		W	1.00 ± 0.15		
		T	0.66 max.	BW1	W
i		BW	0.36 ± 0.10		
		BW1	0.20 ± 0.10	1	
		P	0.64 ± 0.10	-	
			unit:mm		L
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					Г
2.Ele	ectrical Requirements	<u> </u>	.,,	<u></u>	
2.1	Maximum allowable voltage		DC 16 V		
2.2			27V ± 15%	Measuring current	DC 1mA
2.3	Capacitance		27pF ± 10%.	Measuring voltage	1.0 Vrms.
	·	<u> </u>		Measuring frequency	1MHz
2.4	Clamping voltage		50 Vmax.	Impulse waveform	8/20 μ s
2.4	Clamping voltage		ou villax.	Impulse current	1A
				Impulse waveform	8/20 μ s
2.5	Maximum peak curren	t	5A	Repetition times	2 times
					(5 minutes interval)
Note					
 	DATE			APPROVAL (CHECK DESIGN
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CLASSIFICATION		SPECIFICATION	N REF. No.
PRODUCT		MULTILAYER VARISTOR CH	HIP TYPE (Zinc Oxide) 151S-EZJZ-S-C01
PART NUMBER		COMMON SPESIFIC	CATION 6-1
Item		Requirements	Test Specifications
3.M	echanical Requirements		
3.1	Substrate bending	Without mechanical damage	Bending stress 2mm
			Bending speed 1.0mm/sec.
			Hold time 5sec.
3.2	Solderability	Approximately 75% of the termi-	Solder temp. 230±5°C
ا2.د	Soluci aviilty	nals shall be covered with new	Dipping period 4±1 sec.
		}	Dipping period 4±1 sec.
\vdash		solder uniformly	_
3.3	Resistance to	Without mechanical damage	Solder temp. 270±5°C
	soldering heat	ΔV+lmA≦±10%	Dipping period 3.0±0.5 sec.
4.Er	viromental Requirements	T	
4.1	Temperature cycle	Without mechanical damage	Cycles 5 cycles
		ΔV+lmA≦±10%	
			Step Temperature Period
			1 -40±3℃ 30 min.
			2 Room temp. 5 min.
			3 85±5°C 30 min.
			4 Room temp. 5 min.
4.2	Damp heat load	ΔV+lmA≦±10%	Ambient condition 40±2°C, 90∼95%RH
		1	Applied voltage Max.allowable voltage
			Test period 500+24 h
			- 0
4.3	Dry heat load	ΔV+lmA≦±10%	Ambient condition 85±5°C
	-		Applied voltage Max.allowable voltage
			Test period 500+24 h
			- 0
\vdash			40 to 95 C
	perating temperature range	1	-40 to 85 C
Note	: :		•
	DATE		APPROVAL CHECK DESIGN
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CLASSIFICATION			SPECIFICATION	No.
SU	JBJECT		MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide) 151S-EZIZ	
			TEST METHOD (COMMON SPECIFICATION)	6 - 2
	Characteri		Test Method	
S	tandard test c	ondition	Unless otherwise specified all test and measurements shall be made at	a temperature
			of 15~35°C and at a relative humidity of 45~75%RH.	
			If results obtained are doubted a further test should becarried out at a to	emperature of
			20±2°C and a relative humidity of 60∼70%RH.	
2. Electr	rical requirem	ents		
2.1	Max.allowa	ble	The maximum DC voltage that can be applied continuously in the spec	rified operating
	voltage		temperature.	
2.2	Varistor vol	tage	The voltage between two terminals with the specified measuring current	nt 1mA DC
			applied is called V1mA.	
			The measurement shall be made as fast as possible to avoid heat affect	ion.
2.3	Capacitance		Capacitance shall be measured at 1MHz±10%,0.2~2.0Vrms.,0V bias	
2.3	Сараснансе	,	Capacitance shall be incasured at 141112±10/0,0.2 2.0 411115.,0 4 bias	and 25 3 .
2.4	Clamping v	oltage	The maximum voltage between two terminals with the specified standard	ard impulse
			$\operatorname{current}(8/20\mu\mathrm{s})$.	
2.5	Maximum p	eak current	The maximum current within the varistor voltage change of $\pm 10\%$ who	en a standard
			impulse current of $8/20 \mu$ s is spplied two times with an interval of 5 n	ninutes.
2.6	Maximum I	ESD	The maximum ESD within the varistor voltage change of $\pm 30\%$ when	a standard
			impulse ESD is applied.	
			* ESD : Electrostatic Discharge	
Note:	l			

HOKKAIDO MATSUSHITA ELECTRIC CO.,LTD.

teristics uirements e bending oility ce to g heat	MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide) TEST METHOD (COMMON SPECIFICATION) Test Method After soldering specimen on the substrate, 2mm of bending shall be applied. Bending speed: 0.5mm/s. Dip the specimen in solder so that both terminals electrodes are comsubmerged. Use solder H63A(JIS -Z-3282). For the flux, about 25% Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tall After test, the specimen shall be left to stand at room temperature for The change of V1mA and mechanical damage shall be examined.	6 by weight. are completely able below.
uirements e bending bility ce to	After soldering specimen on the substrate, 2mm of bending shall be applied. Bending speed: 0.5mm/s. Dip the specimen in solder so that both terminals electrodes are communications submerged. Use solder H63A(JIS -Z-3282). For the flux, about 25% Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tall After test, the specimen shall be left to stand at room temperature for	6 by weight. are completely able below.
e bending bility	be applied . Bending speed: 0.5mm/s. Dip the specimen in solder so that both terminals electrodes are communications submerged. Use solder H63A(JIS -Z-3282). For the flux, about 25% Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tall After test, the specimen shall be left to stand at room temperature for	6 by weight. are completely able below.
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ce to	Dip the specimen in solder so that both terminals electrodes are communications submerged. Use solder H63A(JIS -Z-3282). For the flux, about 25% Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tall After test, the specimen shall be left to stand at room temperature for	6 by weight. are completely able below.
ce to	submerged. Use solder H63A(JIS -Z-3282). For the flux, about 25% Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tall After test, the specimen shall be left to stand at room temperature for	6 by weight. are completely able below.
	Use tweezer for the holder to dip the specimen. Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tal. After test, the specimen shall be left to stand at room temperature for	are completely
	Dip the specimen in molten solder so that both terminals electrodes a submerged. Before dipping preheat the specimen according to the tal. After test, the specimen shall be left to stand at room temperature for	ble below.
	submerged. Before dipping preheat the specimen according to the tal. After test, the specimen shall be left to stand at room temperature for	ble below.
g heat	After test, the specimen shall be left to stand at room temperature for	
		24±2 hours.
	The change of V1mA and mechanical damage shall be examined.	
iture cycle		-
	•	
	temperature for 24±2 hours. The change of V1mA and mechanical of	lamage shall be
	examined.	
eat load	Solder the specimen to the testing jig. The specimen shall be applied	•
	the Maximum allowable voltage at apecified conditions for specified	I period and then
	stored at room temperature and normal humidity for 24±2 hours.	
	Thereafter, the change of V1mA and mechanical damage shall be ex-	amined.
load	Solder the specimen to the testing jig. The specimen shall be applied	d continuously
	the Maximum allowable voltage at apecified conditions for specified	I period and then
	stored at room temperature and normal humidity for 24±2 hours.	
	Thereafter, the change of V1mA and mechanical damage shall be ex-	amined.
	equirements ature cycle eat load t load	Solder the specimen to the testing jig. Condition the spesimen to ear from step 1 to 4 in this order for the period shown in the table of spe Before the measurement after test, the specimen shall be left to stand temperature for 24±2 hours. The change of V1mA and mechanical dexamined. Solder the specimen to the testing jig. The specimen shall be applied the Maximum allowable voltage at apecified conditions for specified stored at room temperature and normal humidity for 24±2 hours. Thereafter, the change of V1mA and mechanical damage shall be extended to the Maximum allowable voltage at apecified conditions for specified the Maximum allowable voltage at apecified conditions for specified stored at room temperature and normal humidity for 24±2 hours.

CLASSIFICATION	SPECIFICATION	No.
SUBJECT	MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)	151S-EZJZ-S-C01
	TAPED AND REELED PACKAGE SPECIFICATION (COMMON SPECIFICATION)	6 - 4

1. Scope

This specification applies to the taped and reeled packaging for 'MULTILAYER VARISTOR CHIP TYPE (Zinc Oxide)'.

2. Applicable standars

EIAJ (Electric industories assosiation of japan) Standard EIAJ RC-1009B

JIS (Japanese Industrial standard) Standard JIS 0806

3. Packing specificaton

3.1 Structure and dimensions

(1)Carrier tape: Shown in Fig,1(2)Reel: Shown in Fig,2

(3)Packaging : We shall pack suitable in order to prevent damage during transportation

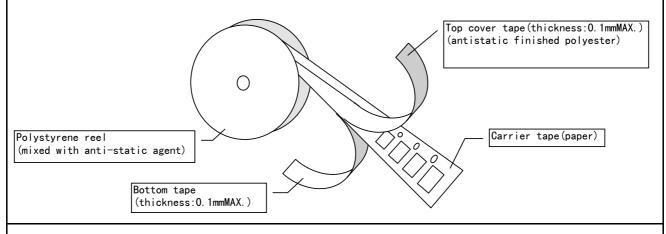
or storage.

3.2 Packing Quantity

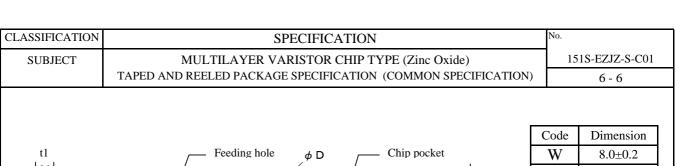
Type	Quantity (pcs./reel)
2 array	4000

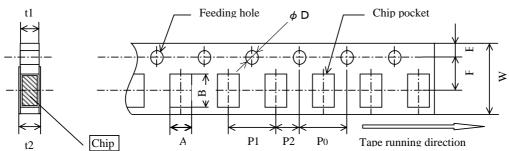
3.3 Structure of taping

(1) The direction of winding of taping on the reel shall be in accordance with the following diagram.



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SUBJECT	MULTILAYER VARIS	151S-EZJZ-S-C01		
	TAPED AND REELED PACKAGE SF	PECIFICATION (COM	MON SPECIFICATION)	6 - 5
(2)Th	e specification of the leader and empty	portion shall be in ac	cordance with the following	ng diagram.
		Components		Leader part
	Vacant position	position	Vacant position	(cover tape)
	0 0 0	0))0	<u> </u>	
Tape end		<u> </u>	<u></u>	
	40mm min.		40mm min.	200mm min.
	(10 pich)		(10 pich)	
		e running direction		
	ing on the reel			
On th	e side of the reel we shall indicate no fe	ewer than the items.		
(1)Pa	rt number			
(2)Qı	antity			
(3)Lo	t number			
4. Efficiency				
4.1 Break	tage strength of the tape			
1.0 N	(approx.1 kgf) or more.			
4.2 Peel	strength of the tape (refer to the followi	ing figure).		
(1)Pe	el angle : 165 to 180 degree from the	e tape adhesive face.		
(2)Pe	el velocity : 300 mm per min.			
(3)Pe	el strength : 0.1 to 0.7 N (approx. 10 t	to 70 gf).		
		Co	ver tape peeling direc	tion
	Cover ta	ape _		
	165 ∼ 180°			
	100 100			
			$\overline{}$	
		\	<u> </u>	
4.3 Barrs	on tana	└─ Carı	rier tape	
	e shall be no barrs proventing section w	vhan producte ara taka	n out	
	ng of products	men products are take	n Out.	
	nissing of products shall be 0.1% or les	se ner reel and thorach	all he no continuous	
	ng of products snan be 0.1% or les	os per reer and mere sn	ian de no continuous	
	rence to the tape			
	_	ana or hottom tono		
Proal	icts shall be not be stuck to the cover ta	ipe or bouom tape.		



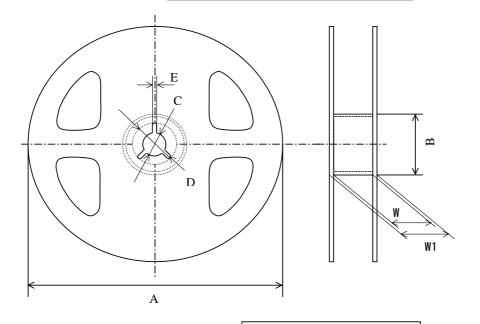


Code	Dimension	
W	8.0±0.2	
F	3.50±0.05	
Е	1.75±0.10	
P0	4.0±0.1	
P1	4.0±0.1	
P2	2.00±0.05	
D0	φ 1.5 +0.1 -0	

(unit:mm)

Code	Dimension
A	1.18 ± 0.05
В	1.63 ± 0.05
t1	1.1 max.
t2	1.4 max.

Fig.1 Carrier tape dimension



Code	Dimension
A	φ 180 +0 -3. 0
В	φ 60±0.5
C	13.0±0.5
D	21.0±0.8
Е	2.0±0.5
W	9.0±0.3
W1	11.4±1.0

(unit:mm)

Fig.2 Reel Dimension

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Precautions for Safety

The Multilayer Varistor (hereafter referred to as "The Varistors") may fail in a short circuit mode on in an open-circuit mode, when subjected to severe conditions of electrical, environmental and/or mechanical stresses beyond the specified "Ratings" and specified "Conditions" in the Catalog and the Specifications, resulting in burnout, flaming or glowing in the worst case.

Following "Precautions for Safety" and "Application Notes" shall be taken in your major consideration. If you tyr to apply our product for the following electronic equipments, or have any question, Please contact us.

- Aitificial satellite, cosmic rocket
- Aircraft
- Seabed repeater
- •Traffic/transport system(automobil,aircraft,rolling stock,ship,traffic signal control equipment)
- Electric power plant(nuclear power,thermal power,hydraulic power generation)
- Medical equipment
- •Information processing system
- Seculity system
- Rotating machine
- 1. Operating Conditions and Circuit Design
 - (1) The Varistors shall not be operated beyond the specified "Ratings" and "Environmental Conditions" in the Catalog or the Specifications to prevent them from deterioration, brealdown, flaming
 - 1.1 The Varistors shall not be operated beyond the specified "Operating Temperature Range" in the Catalog or the Specifications.
 - 1.2 The Varistors shall not be in "AC power circuit".
 - 1.3 The Varistors shall not be operated exceeding the specified "Maximum Allowable Voltage" in the Catalog or the Specification.
 - 1.4 The Varistors shall not be subjected to energy levels above their specified "Maximum energy Ratings" in the Catalog or the Specifications.
 - (2) The Varistors shall be operated correctly under following conditions to prevent Varistors from causing mechanical damages and ruptures and to protect human from serious injuries.
 - 2.1 The Varistors shall not be operated exceeding the specified "Maximum Allowable Voltage" in the Catalog or the Specification.
 - 2.2 The Varistors shall not be operated exceeding the specified "Maximum Peak Current Ratings" in the Catalog or the Specification.
 - (3) It is recommended that the Varistors, if not fused , shall not located away from other combustibe components.

Note:			

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SUBJECT	MULTILAYER VARISTOR CHIP TYPE(Zinc Oxide)	151S-EZJZ-C04-R01
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2. Restriction on environmental conditions

The varistors shall not be operated and / or stored under following environmental conditions.

- (1) Environmental conditions
 - (a) To be exposed directly to water or salt water.
 - (b) Under conditions of dew formation.
 - (c) Under conditions of corrosive atmosphere such as hydrogen sulfide, sulfurous acid, chlorine or ammonia etc..
- (2) Under severe conditions of extreme vibrations or shocks.

3. Precautions for Printed-Circuit-Board Design

3.1 Selection of printed circuid board

When the varistors are mounted and soldered on an "Aluminum substrate", the substrate has infuluences on varistors reliabilities against "Temperature cycles" and "Heat shock" because of difference of thermal expansion coefficient between them. It shall be carefully confirmed that the actual board applied does not deteriorate the characteristics of the varistors.

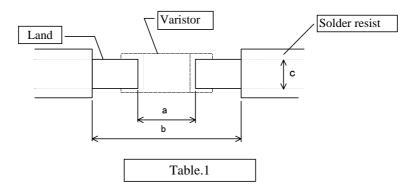
3.2 Design of land pattern

Recommended dimensions of lands; As shown in table 1 and Fig. 1

(1) If the land area is too large, the amount of solder will become so large that the cracks will occur in the varistor when soldering.

The land size shall be not exceed the varistor width.

Fig.1 Recommended land dimensions(Ex.)



(Unit:mm)

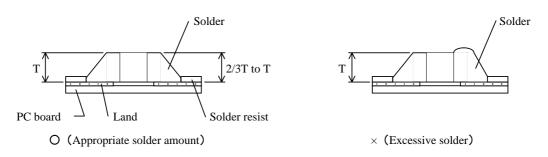
Туре	Co	Component Flow soldering Reflow soldering		Flow soldering		ng			
(size)	dimension								
	L	W	T	a	b	c	a	b	c
0402(1005)	1.0	0.5	0.5	1	1	1	0.5 to 0.6	1.5 to 1.7	0.5 to 0.6
0603(1608)	1.6	0.8	0.8	0.8 to 1.0	2.0 to 2.6	0.6 to 0.8	0.8 to 1.0	2.0 to 2.6	0.8 to 1.0
0805(2012)	2.0	1.25	0.85	1.0 to 1.4	3.0 to 3.8	0.8 to 1.0	0.8 to 1.2	2.4 to 3.2	1.0 to 1.2

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(2) The sizes of lands shall be equal between in the right half and in the left half are different, the half of which the amount of solder is larger than of the other is soldified later.

Fig.2 Recommended solder amount

This may apply stress to one half and the cracks occur in the varistor.



- (3) In the following conditions, the lands of varistor shall be divided other lands by solder resist. If there is no resist, amounts of solder will become so large that the cracks will occur in the varistor when soldering.
 - i) other chip components contact the varistor
 - ii) lead components are directly contacted to the varistor
 - iii) common lands (chassis,stc.) are close to the varistor

3.3 Components layout

When placing / mounting the varistor near an area which is apt to bend or a grid groove on bord, it is advisable to have both electrodes subjected to uniform stresses, or to position the varistors electrodes at right angles to the grid groove or bending line.

(1) Mounting density and spaces

Placements in too narrow spaces between components may cause "Solder Bridges", during soldering . The minimum space between components shall be 0.5mm in view of the positioning tolerances of the mounting machines and the dimensional tolerances of the components and PC boards.

- (2) Applications of solder resist are effective to prevent solder bridges and to control amounts of solder on PC boards.(As shown in Table 2)
 - (a) Solder resist shall be utilized to equalize the amounts of solder on both sides.
 - (b) If varistor of arranged in succession, and if they are mounted together with a component with a lead of positioned near a chassis etc., solder resist shall be used to divide the pattern.

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N	n	16	7,

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Table 2 Applications of Solder Resist

	Good Ex.	Bad Ex.
Two or more chip componnents contact each other.	Solder resist	
Lead components are directly connected to chip components.	Solder resist	
Common lands(chass is ,ets,) are close to chip components.	Solder resist	

4. Precautions for Mounting for assembly

4.1 Storage

- (1) Varistors shall not be stored under servers conditions of high temperature and humidity . Store them indoors under at 5 to 40° C or less and 20 to 70%RH or less.
- (2) If the storage place is humidity, dust, and contains corrosive gasses (hydrogen sulfide, sulfurous acid, hydrogen chioride and ammonia etc.), the solderability of the external electrode may be reduced. Storage in a place exposed to heat and direct sunlight causes deformation of the reels and tapes of tapepackaged products and adhesion of components to tapes, which results in troubles in case of mounting.
- (3) The period of storage not exceed 6 months. For products stored for more than 6 months, their solderability shall be checked before they are used.

4.2 Adhesives for mounting

- (1) The viscosity of a adhesive for mountings shall be such that the adhesive does not flow off on the land during it's curing.
- (2) If the adhesive is too low its viscosity, mounted components may be out alignment after or during soldering.
- (3) The adhesive shall not be corrosive or chemically active

Note:			

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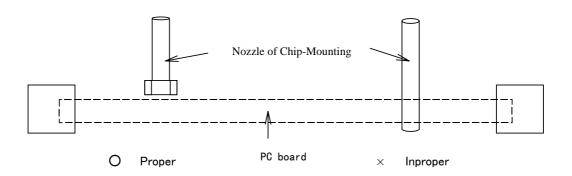
- (4) The amount of adhesive shall be such that the adhesive does not flow off or be out of alignment.
- (5) Adhesives for mountings can be cured by ultraviolet or infrared radiation. Inorder to prevent the terminal electrodes of the varistors from oxidizing. The curing shall be done at conditions of 160°C max., for 2 minutes max..

4.3 Chip mounting consideration

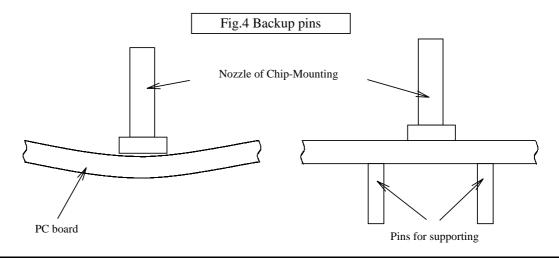
In mounting the varistors/components on a printed circuid board, /any bending and expanding force against them shall be kept minimum to prevent them from bending damaged or cracked. Following precautions and recommendations shall be observed carefully in the process.

- (1) Maximum stroke of the vacuum nozzle shall be adjusted so that the pushing force to the printed circuid board shall be limitted to a static load of 1 to 3N(100 to 300gf).
- (2) Maximum stroke of the nozzle shall be adjusted so that the maximum bending of printed circuit board does not exceed 0.5mm.

Fig.3 Bottom dead point height of the vacuum nozzle



(3) The printed circuit board shall be supported by means of adequate supporting pins.



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4.4 Soldering flux and solder

(1) Soldering flux

The content of halogen in the flux shall be 0.2wt% (Cl conversion) of less Rosin-based and non-activated soldering flux is recommended.

(2) Water soluble type soldering flux

In case of water soluble type soldering flux being applied, the flux residue on the surface of P.C. board may have influences on the reliability of the components and cause deterioration and failures of them.

(3) Solder

An eutectic solder (Sn:63,Pb:37) is recommended.

4.5 Soldering

4.5.1 Flow soldering

In flow soldering process, abnormal and large thermal and mechanical stresses, caused by "Temperature Gradient" between the mounted varistor and melted solder in a soldering bath, may be applied directly to the varistors, resulting in failures and damages of the varistors.

So it is esscential that soldering process shall be controlled to the following recommended conditions.

(1) Application of flux

The soldering flux shall be applied to the mounted varistor thinly and uniformly by forming method.

(2) Preheating

The mounted varistors/components shall be preheated sufficiently so that the "Temperature Gredient" between the varistors/components and the melted solder shall be 150°C or below.

(3) Immersion to soldering bath

The varistors shall be immersed into a soldering bath of 240 to 250°C for 3 to 5 seconds.

(4) Cooling

The varistor shall be cooled gradualy to room ambient temperature with the cooling temperature rates of $8 \,^{\circ}\text{C/s}$ max. from 250 to 170 $\,^{\circ}\text{C}$ and $4 \,^{\circ}\text{C/s}$ max. from 170 to 130 $\,^{\circ}\text{C}$.

(5) Flux cleaning

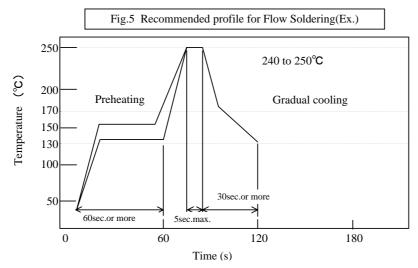
When the varistors are immersed into cleaning solvent, it shall be confirmed that the surface temperature of devices do not exceed 100° C.

(6) There is no problem with twice flow soldering under the conditions described in the diagram [Recommended Profile for Flow Soldering (Example)] below.

Care shall, however, be taken to prevent board warp or bend.

Note:			

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4.5.2 Reflow soldering

In reflow soldering process, the mounted varistors/components are generally heated and soldered by a thermal conduction system such as an "Infrared rediation and hot blast soldering system " or a "Vapour Phase Soldering System (VPS)". Large temperature gradients such as a rapid heating and cooling in the process may cause electrical failures and mechanical damages of the device.

It is essential that the soldering process shall be controlled by the following recommended conditions and precautions.(See Fig.6)

(1) Preheating 1

The mounted varistors/components shall be preheated sufficiently , for 60 to 90 seconds so that the surface temperatures of them to be 140 to 160° C.

(2) Preheating 2

After "Preheating 1", the mounted varistors/components shall be heated to the elevated temperatures of 150 to 200°C for 2 to 5 seconds.

(3) Soldering

The mounted varistors/components shall be heated under the specified heating conditions (200 to 240 to 200°C for total of 20 to 40 seconds, See Fig. 10) and shall be soldered at the maximum temperature of 240°C to 10 seconds or less.

(4) Cooling

After the soldering, the mounted varistors/components shall be granually cooled to room amnient temperature for preventing mechanical damages such as crackings of the devices.

(5) Flux Cleaning

When the varistors are immersed into cleaning solvent, it shall be confirmed that the surface temperature of devices do not exceed 100°C.

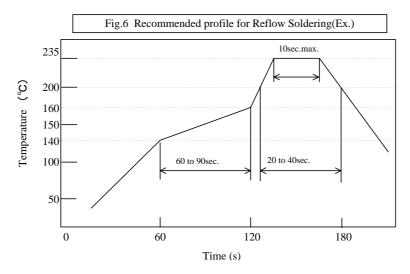
Note:		

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(6) There is no problem with twice flow soldering under the conditions described in the diagram [Recommended Profile for Flow Soldering(Example)] below.

Care shall ,however ,be taken to prevent board warp or bend.

Note: If the mounted varistors/components are partially heated in the soldering process, the devices may be separated from the printed circuit board by surface tension of partially melted solder, and stand up like a "Tomb stone".



4.5.3 Hand Soldering

In hand soldering of the varistors, large temperature gradient between preheated the varistors and the tip of soldering iron may cause electrical failures and mechanical damages such as crackings or breaking of the devices. The soldering shall be carefully controlled and carried out so that the temperature gradient is kept minimum with following recommended conditions for hand soldering.

- (1) Solder
 - ϕ 1mm Thresd euetic solder with soldering flux in the core.(Rosin-based,and non-sctivated flux is recommended)
- (2) Preheating

The varistors shall be preheated so that "Temperature Gredient" between the devices and the tip of soldering iron is 150°C or below.

- (3) Solder Iron
 - Rated Power of 20W max. with 3mm soldering iron tip in diameter.
- (4) Temperature of soldering iron tip; 300°C max.

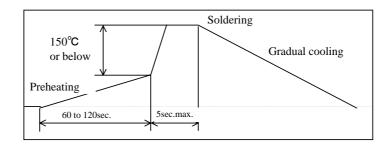
 (The required amount of solder shall be melted in advance on the soldering tip.)
- (5) Cooling

After the soldering, the varistors shall be cooled gradually at room ambient temperature.

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Fig.7 Recommended Soldering by Hand Soldering(Ex.)



4.6 Post Soldering Cleaning

- (1) Residues of corrosive soldering fluxes on the PC board after cleaning may greatelly have influences on the electrical characteristics and the reliability (such as humidity resistance) of the varistors which have been mounted on the board, it shall be confirmed that the characteristics and the reliability of the devices are not affected by the applied cleaning conditions.
- (2) Solubility of alternative cleaning solvent such as alcohol etc., is inferior to that of freon cleaning solvent in the flux cleaning.
 - So in a case of alternative cleaning solvents applied, fresh cleaning solvent always shall be used, and sufficient rinsing and drying shall be carried out.
- (3) When an ultrasonic cleaning is applied to the mounted varistors on PC boards, following conditions are recommended for preventing failures or damages of ultrasonic waves.

Frequency; 29kHz max.

Period; 5 minutes max.

4.7 Process Inspection

When the surface of a printed board on which the varistors has been mouted is coated with resin to protect against moisture and dust, it shall be confirmed that the protective coat does not have influences on reliability of the varistors in the actual equipment.

- (1) Coating meterials, such as being corrosive and chemically active, shall not be applied to the varistors and other components.
- (2) Coating materials with large exansivity shall not be applied to the varistors for preventing failures or damages (such as crackings) of the devices in the curing process.

Note:			

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(1) A o (2) E a	Dividing / Breaking of PC Boards Abnormal and excessive mechanical stresses, such as bending or expanding force on the on the printed circuid board, shall be kept minimum in the dividing / breaking. Dividing / Breaking of the PC boards shall be done carefully at moderate speed by using paratus to prevent the varistors on the boards from mechanical damages.	_
5. Product p	place	
Hokkaido	o Matsushita Electric Co.,Ltd. / 1037-2 , Kamiosatsu, Chitose-shi , Hokkaido , Japan	
Note:		

HOKKAIDO MATSUSHITA ELECTRIC CO.,LTD.

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